

**Notice of References Cited**

Application/Control No.

10/589,837

Applicant(s)/Patent Under  
Reexamination  
BEUN ET AL.

Examiner

MICHAEL R. VAUGHAN

Art Unit

2431

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,797,031 A	08-1998	Shapiro et al.	710/8
*	B	US-2002/0172366 A1	11-2002	Peterka et al.	380/277
*	C	US-2004/0052379 A1	03-2004	Nishimoto et al.	380/281
*	D	US-2004/0242150 A1	12-2004	Wright et al.	455/003.02
*	E	US-2005/0141712 A1	06-2005	Koo et al.	380/231
*	F	US-2005/0165937 A1	07-2005	Genevois, Christophe	709/229
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
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	X				

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